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PRODUCT RELIABILITY REPORT FOR

MAXQ622, Rev A2

Maxim Integrated Products

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Prepared by:

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Conclusion:

The following qualification successfully meets the quality and reliability standards required of all Maxim products:

MAXQ622, Rev A2

In addition, Maxim's continuous reliability monitor program ensures that all outgoing product will continue to meet Maxim's quality and reliability standards. The current status of the reliability monitor program can be viewed at http://www.maxim-ic.com/TechSupport /dsreliability.html.

Device Description:

A description of this device can be found in the product data sheet. You can find the product data sheet at http://dbserv.maxim-ic.com/l_datasheet3.cfm.

Reliability Derating:

The Arrhenius model will be used to determine the acceleration factor for failure mechanisms that are temperature accelerated.

AfT = exp((Ea/k)*(1/Tu - 1/Ts)) = tu/ts AfT = Acceleration factor due to Temperature tu = Time at use temperature (e.g. 55°C) ts = Time at stress temperature (e.g. 125°C) k = Boltzmann's Constant (8.617 x 10-5 eV/°K) Tu = Temperature at Use (°K) Ts = Temperature at Stress (°K) Ea = Activation Energy (e.g. 0.7 ev)

The activation energy of the failure mechanism is derived from either internal studies or industry accepted standards, or activation energy of 0.7ev will be used whenever actual failure mechanisms or their activation energies are unknown. All deratings will be done from the stress ambient temperature to the use ambient temperature.

An exponential model will be used to determine the acceleration factor for failure mechanisms, which are voltage accelerated.

AfV = exp(B*(Vs - Vu)) AfV = Acceleration factor due to Voltage Vs = Stress Voltage (e.g. 7.0 volts) Vu = Maximum Operating Voltage (e.g. 5.5 volts) B = Constant related to failure mechanism type (e.g. 1.0, 2.4, 2.7, etc.)

The Constant, B, related to the failure mechanism is derived from either internal studies or industry accepted standards, or a B of 1.0 will be used whenever actual failure mechanisms or their B are unknown. All deratings will be done from the stress voltage to the maximum operating voltage. Failure rate data from the operating life test is reported using a Chi-Squared statistical model at the 60% or 90% confidence level (Cf).

The failure rate, Fr, is related to the acceleration during life test by:

Fr = X/(ts * AfV * AfT * N * 2) X = Chi-Sq statistical upper limit N = Life test sample size Failure Rates are reported in FITs (Failures in Time) or MTTF (Mean Time To Failure). The FIT rate is related to MTTF by:

MTTF = 1/Fr

NOTE: MTTF is frequently used interchangeably with MTBF.

The calculated failure rate for this device/process is:

	•								
FAILURE RATE:	MTTF (YRS):	43947	FITS:	2.6					
	DEVICE HOURS:	352752046	FAILS:	0					
Only data from Operating Life or similar stresses are used for this calculation.									
The parameters used to calculate this failure rate are as follows:									
Cf: 60%	Ea: 0.7 B: 0	Tu: 2	25 °C	Vu: 3.6 Vol	s				
The reliability data follows.	At the start of this data is	the device info	rmation. Th	e next section is th	e				

The reliability data follows. At the start of this data is the device information. The next section is the detailed reliability data for each stress. The reliability data section includes the latest data available and may contain some generic data. **Bold** Product Number denotes specific product data.

Device Information	on:								
Process:				signal, Embedded Fla	ish,	General	Purpo	se, Tw	/0
Dessivation		Poly Fi SiO/Sil		/3.3V Polyimide - No					
Passivation: Die Size:		510/511 111 x 1							
Number of Trans	sistors.								
Interconnect:			um / 0.5% Cop	per					
Gate Oxide Thic	kness:	32 Å							
ESD HBM									
DESCRIPTION	DATE	CODE/PRODU	JCT/LOT	CONDITION	RE	ADPOIN	QTY	FAILS	FA#
ESD SENSITIVITY	0946	MAXQ622	QN091481C	JESD22-A114 HBM 500 VOLTS	1	PUL'S	3	0	
ESD SENSITIVITY	0946	MAXQ622	QN091481C	JESD22-A114 HBM 1000 VOLTS	1	PUL'S	3	0	
ESD SENSITIVITY	0946	MAXQ622	QN091481C	JESD22-A114 HBM 2000 VOLTS	1	PUL'S	3	0	
ESD SENSITIVITY	0946	MAXQ622	QN091481C	JESD22-A114 HBM 4000 VOLTS	1	PUL'S	3	0	
					Total:			0	
LATCH-UP									
DESCRIPTION	DATE	CODE/PRODU	JCT/LOT	CONDITION	RE	ADPOIN	QTY	FAILS	FA#
LATCH-UP I	0946	MAXQ622	QN091481C	JESD78A, I-TEST 125C			6	0	
LATCH-UP V	0946	MAXQ622	QN091481C	JESD78A, V-SUPPLY TEST 125C			6	0	
					Tota	al:		0	
OPERATING LIFE									
DESCRIPTION	DATE	CODE/PRODU	JCT/LOT	CONDITION	RE	ADPOIN	QTY	FAILS	FA#
HIGH TEMP OP LIFE	0814	MAXQ1103	QN089294A	125C, 3.6V (PSA) & 2.0V (PSB)	100	0 HRS	77	0	
Rev B, 1/3/08									

HIGH TEMP OP LIFE	0828	MAXQ2010	QK086138C	125C, 3.6 VOLTS	1000	HRS	76	0	
HIGH TEMP OP LIFE	0837	MAX2990	QN096322A	125C, 3.6V (PSA) & 2.0V (PSB)	1000	HRS	77	0	
HIGH TEMP OP LIFE	0851	MAXQ3108	QJ091011AC	125C, 3.6 VOLTS	192	HRS	73	0	
HIGH TEMP OP LIFE	0851	MAXQ610	QJ091123AB	125C, 3.6V (PSA) & 2.0V (PSB)	1000	HRS	77	0	
HIGH TEMP OP LIFE	0906	MAXQ61H	QJ091049AB	125C, 3.6 VOLTS	192	HRS	45	0	
HIGH TEMP OP LIFE	0909	MAXQ8913	NQQ8ZAD	125C, 3.6V (PSA) & 5.0V (PSB)	192	HRS	77	0	
HIGH TEMP OP LIFE	0934	MAXQ1103	QN101437A	125C, 3.6V (PSA) & 2.0V (PSB)	192	HRS	77	0	
HIGH TEMP OP LIFE	0946	MAXQ622	QN091481C	125C, 3.6V (PSA) & 5.5V (PSB)	192	HRS	77	0	
					Total:			0	
W/E ENDURANCE A	ND DA	TA RET'N							
DESCRIPTION	DATE	CODE/PRODUCT/	LOT	CONDITION	READ	POIN	QTY	FAILS	FA#
WRITE CYCLE STRESS (KCYS)	0828	MAXQ2010	QK086138C	85 C, 3.6 VOLTS	20	KCYS	77	0	
STORAGE LIFE	0828	MAXQ2010	QK086138C	150C	1000	HRS	77	0	
WRITE CYCLE STRESS (KCYS)	0834	MAXQ1103	QN099609A	85 C, 3.6V (PSA) & 2.0V (PSB)	20	KCYS	77	0	
STORAGE LIFE	0834	MAXQ1103	QN099609A	150C	1000	HRS	77	0	
WRITE CYCLE STRESS (KCYS)	0837	MAX2990	QN096322A	85 C, 3.6V (PSA) & 2.0V (PSB)	1	KCYS	77	0	
STORAGE LIFE	0837	MAX2990	QN096322A	150C	1000	HRS	77	0	
WRITE CYCLE STRESS (KCYS)	0851	MAXQ3108	QJ091011AC	85 C, 3.6 VOLTS	1	KCYS	77	0	
STORAGE LIFE	0851	MAXQ3108	QJ091011AC	150C	96	HRS	77	0	
WRITE CYCLE STRESS (KCYS)	0851	MAXQ610	QJ091123AB	85 C, 3.6V (PSA) & 2.0V (PSB)	20	KCYS	77	0	
STORAGE LIFE	0851	MAXQ610	QJ091123AB	150C	1000	HRS	76	0	
WRITE CYCLE STRESS (KCYS)	0904	MAXQ1103	QN091170B	85 C, 3.6V (PSA) & 2.0V (PSB)	20	KCYS	77	0	
STORAGE LIFE	0904	MAXQ1103	QN091170B	150C	1000	HRS	77	0	
WRITE CYCLE STRESS (KCYS)	0909	MAXQ8913	NQQ8ZAD	85 C, 3.6V (PSA) & 5.0V (PSB)	1	KCYS	77	0	
STORAGE LIFE	0909	MAXQ8913	NQQ8ZAD	150C	96	HRS	77	0	
WRITE CYCLE STRESS (KCYS)	0934	MAXQ1103	QN101437A	85 C, 3.6V (PSA) & 2.0V (PSB)	20	KCYS	77	0	
STORAGE LIFE	0934	MAXQ1103	QN101437A	150C	500	HRS	76	0	
					Total:			0	
FAILURE RATE:	_	MTTF (YRS)		947 FITS:	2.6				
	D	EVICE HOURS	: 352752	046 FAILS:	0				